## Application/Control No. Applicant(s)/Patent Under Reexamination 10/656,512 AWAKURA ET AL. Notic of R ferenc s Cited Examiner Art Unit Page 1 of 1 Tuan T Dinh 2827 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-5,835,313 Α 11-1998 Sato et al. 360/317 US-5,959,813 В 09-1999 Watanabe et al. 360/126 US-6,134,079 C 10-2000 Koshikawa, Takao 360/126 US-6,154,349 11-2000 Kanai et al. D 360/324.12 Ε US-6,469,868 10-2002 Yamamoto et al. 360/126 US-F US-G US-Н USı US-J US-US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY JP 10105961 A Ν 04-1998 Japan SEO, YUZO G11B 05/82 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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